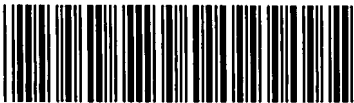


Search Notes

Application/Control No.

10/784,989

Examiner

Thi Q. Le

Applicant(s)/Patent under
Reexamination

TAKAHARA ET AL.

Art Unit

2613

SEARCHED

Class	Subclass	Date	Examiner
398	29,27,81,1 47,192	5/10/2007	TL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
398	29,27,81	5/10/2007	TL
398	147, 192	5/10/2007	TL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST image and keyword search in US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT and IBM_TDB (see EAST search history attached)	5/10/2007	TL
NPL Search (IEEE xplore, INSPEC, SPIE etc.)	5/10/2007	TL